

ENGINEERING DEPT.

PRODUCT SPECIFICATION

SPEC.NO.: SPCU001H

For CU01 Series USB Connector Plug & Receptacle

PAGE: 1/4

1. SCOPE:

REVISIONS

This specification covers performance, tests and quality requirements for Universal Serial Bus (USB) plug and receptacle connectors. These connectors are cable mounted plug and PC Board mounted receptacle connectors

- 2. APPLICABLE STANDARDS: EIA 364 MIL - STD - 202 Methods for test of connectors for electronic equipment
- 3. APPLICABLE SERIES NO.: CU01 Series
- 4. SHAPE, CONSTRUCTION AND DIMENSIONS See attached drawings

ECN09228

- 5. MATERIALS See attached drawings
- 6. ACCOMMODATED P.C.BOARD6.1 Thickness: 1.6 mm (.063")6.2 P.C. Board Layout: See attached drawings



REVIEWED : <u>Alex</u> APPROVED : <u>Alex</u> VERIFIED : <u>Sun</u>.



| REVISIONSECN09228For CU01 Series USB Connector Plug & ReceptaclePAGE: 2/4 | |
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7. ELECTRICAL PERFORMANCE:

| | ITEM | TEST CONDITION | REQUIREMENT |
|-----|---------------------------|--|----------------------|
| 7.1 | Rated current and voltage | | 1.5A 30V AC (r.m.s.) |
| 7.2 | Contact resistance | EIA 364 - 23 Subject mated contacts assembled in housing to 20 mV max. open circuit at 100 mA max. | 30 mΩmax. |
| 7.3 | Dielectric strength | EIA 364 - 20 Test between adjacent contacts of mated and unmated connector assemblies | 750 VAC at sea level |
| 7.4 | Insulation resistance | EIA 364 - 20 Test between adjacent contacts of mated and unmated connector assemblies | 1000 MΩ min. |
| 7.5 | Capacitance | EIA 364 - 30 Test between adjacent circuits of unmated connectors at 1 KHz | 2 pF max. |

8. MECHANICAL PERFORMANCE:

| | ITEM | TEST CONDITION | REQUIREMENT |
|-----|-----------------------------------|--|--------------------------|
| 8.1 | Wire size | Specified wire size | Accepts AWG #20~#28 |
| 8.2 | Terminal crimp tensile | When crimped AWG #20 size wire | More than 7.0 Kgf |
| | strength | When crimped AWG #22 size wire | More than 5.0 Kgf |
| | | When crimped AWG #24 size wire | More than 3.0 Kgf |
| | | When crimped AWG #26 size wire | More than 2.0 Kgf |
| | | When crimped AWG #28 size wire | More than 1.3 Kgf |
| 8.3 | Terminal insertion force | Insertion speed 25± 3 mm per minute into plug housing | Less than 800 gram |
| 8.4 | Contact retain force in insulator | Retention speed 25 ± 3 mm per minute from | Plug: 1.0 Kgf min. |
| | | insulator | Receptacle: 0.8 Kgf min. |
| 8.5 | Mating force | EIA 364 - 13 | 3.57 Kgf (35N) max. |
| | | Measure force necessary to mate connector assemblies at maximum rate of 12.5 mm per minute | |
| 8.6 | Unmating force | EIA 364 - 13 | 1.02 Kgf (10N) min. |
| | | Measure force necessary to unmate connector assemblies at maximum rate of 12.5 mm per minute | |



| ENGINEERING DEPT. | | G DEPT. | PRODUCT SPECIFICATION | SPEC.NO.: | SPCU001H | |
|--------------------|----------------|--|---|---|-----------|--|
| REVISIONS ECN09228 | | ECN09228 | For CU01 Series USB Connector Plug & Receptacle | PAGE: | 3/4 | |
| | | | | | | |
| | IT | EM | TEST CONDITION | REQUIREMENT | | |
| 8.7 | Cable Reten | tion | Apply axial load of 2.55 Kgf (25N) to the | Cable shall not dislodge | | |
| 8.8 | 3.8 Durability | | EIA 364 - 09 Mate and unmate connector assemblies for 1500 cycles at maximum rate of 200 cycles per hour | Appearance: No dama and shall meet para | | |
| 9. EN | VIRONMEN | TAL PERF | ORMANCE: | | | |
| | ITEM | 1 | TEST CONDITION | REQUIR | EMENT | |
| 9.1 | Vibration | Sut | A 364 - 28 Condition V Test letter A nject mated connectors to 5.35 G's rms een minutes in each of | No discontinuities of 1 μs or longer duration | | |
| 9.2 | Physical sho | Sub pul: Thr | A 364 - 27 Condition H bject mated connectors to 30 G's half - sine shock ses of 11 ms duration ee shocks in each direction applied along three cually perpendicular planes , 18 total shocks | No discontinuities of 1 μs or longer duration | | |
| 9.3 | | | -Lead Process | Minimum: | | |
| | | Sol | dering time: 5 ± 0.5 second | 90% of immer | sed area | |
| | | Sol | dering pot: 230 ± 5°C | | | |
| | | Lea | nd-Free Process | | | |
| | | Sol | dering time: 3 ± 0.5 second | | | |
| | | | dering pot: 245 ± 5°C | | | |
| 9.4 | Resistance to | | -Lead Process | No damage | | |
| | soldering hea | ^{at} Sol Sol Lea | dering time: 5± 0.5 second dering pot: 260± 5°C ad-Free Process fer recommended IR temperature profile | | to damage | |
| 9.5 | Temperature | Sut life | A 364 - 17 Test Condition 3 Method A oject mated connectors to temperature at 85°C for 250 hours condition samples with 10 cycles durability | Appearence: No damage and shell meet para 7.2 | | |
| 9.6 | Humidity | EIA Sut | A 364 - 31 Method II Test Condition A nject mated connectors to 96 hours at 40°C n 90 to 95% RH | Appearance: No damage and shell meet para 7.3 & 7.4 | | |



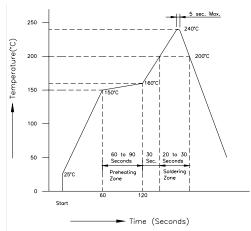
| ENGINEERING DEPT.REVISIONSECN09228 | | PRODUCT SPECIFICATION | SPEC.NO.: | SPCU001H |
|------------------------------------|------|--|---|---|
| | | 8 For CU01 Series USB Connector Plug & Receptacle | PAGE: | 4/4 |
| ITEM | 1 | TEST CONDITION | REQUIREMENT | |
| Thermal sho | | ubject mated connectors to five cycles between | Appearance: No damage and shell meet para 7.3 & 7.4 | |
| Salt spray | 2 | olution: 5± 1% pray time: 48± 4 hours | Appearance: No damage Contact resistance: Less than twice of initial | |
| | ITEM | ITEM Thermal shock E Salt spray T Salt spray S S | VISIONS ECN09228 Plug & Receptacle ITEM TEST CONDITION Thermal shock EIA 364 - 32 Test Condition I Subject mated connectors to five cycles between -55°C and 85°C | VISIONSECN09228Plug & ReceptaclePAGE:ITEMTEST CONDITIONREQUIRThermal shockEIA 364 - 32 Test Condition I Subject mated connectors to five cycles between -55°C and 85°CAppearance: N and shell mee 7.3 & 7.4Salt sprayTemperature: 35± 3°C Solution: 5± 1% Spray time: 48± 4 hoursAppearance: N Contact resist Less than twice |

10. AMBIENT TEMPERATURE RANGE:

Storage Temperature: -40°C to 60°C ; Operating Temperature: 0°C to 85°C

11. Recommended IR Reflow Temperature Profile:

11.1 Using Typical Solder Paste



11.2 Using Lead-Free Solder Paste

